

# AM26LV31E-EP

SLLS947-NOVEMBER 2008

# LOW-VOLTAGE HIGH-SPEED QUADRUPLE DIFFERENTIAL LINE DRIVER WITH ±15-kV IEC ESD PROTECTION

## **FEATURES**

- Meets or Exceeds Standards TIA/EIA-422-B and ITU Recommendation V.11
- Operates From a Single 3.3-V Power Supply
- ESD Protection for RS422 Bus Pins
  - ±15-kV Human-Body Model (HBM)
  - ±8-kV IEC61000-4-2, Contact Discharge
  - ±15-kV IEC61000-4-2, Air-Gap Discharge
- Switching Rates up to 32 MHz
- Propagation Delay Time ... 8 ns Typ
- Pulse Skew Time . . . 500 ps Typ
- High Output-Drive Current . . . ±30 mA
- Controlled Rise and Fall Times ... 5 ns Typ
- Differential Output Voltage With 100-Ω Load . . . 2.6 V Typ
- Accepts 5-V Logic Inputs With 3.3-V Supply
- Ioff Supports Partial-Power-Down Mode
  Operation
- Driver Output Short-Protection Circuit
- Glitch-Free Power-Up/Power-Down Protection

# SUPPORTS DEFENSE, AEROSPACE, AND MEDICAL APPLICATIONS

- Controlled Baseline
- One Assembly/Test Site
- One Fabrication Site
- Available in Extended (-55°C/105°C) Temperature Range<sup>(1)</sup>
- Extended Product Life Cycle
- Extended Product-Change Notification
- Product Traceability

D PACKAGE (TOP VIEW)						
1A [ 1Y [ 1Z [ 2Z [ 2Y [ 2A [ GND ]	1 2 3 4 5 6 7 8	Ο	16 15 14 13 12 11 10 9	V <sub>CC</sub>   4A   4Y   4Z   3Z   3Y   3A		

(1) Additional temperature ranges are available – contact factory

## **DESCRIPTION/ORDERING INFORMATION**

The AM26LV31E is a quadruple differential line driver with 3-state outputs. This driver has  $\pm$ 15-kV ESD (HBM and IEC61000-4-2, Air-Gap Discharge) and  $\pm$ 8-kV ESD (IEC61000-4-2, Contact Discharge) protection. This device is designed to meet TIA/EIA-422-B and ITU Recommendation V.11 drivers with reduced supply voltage.

The device is optimized for balanced-bus transmission at switching rates up to 32 MHz. The outputs have high current capability for driving balanced lines, such as twisted-pair transmission lines, and provide a high impedance in the power-off condition.

The AM26LV31ES is characterized for operation from -55°C to 105°C.

#### **ORDERING INFORMATION**

T <sub>A</sub>	PACKAGE <sup>(1)(2)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
–55°C to 105°C	SOIC – D	Tape and reel	AM26LV31ESDREP	A26LV31ESP	

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.



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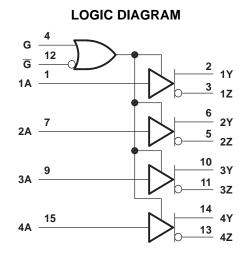


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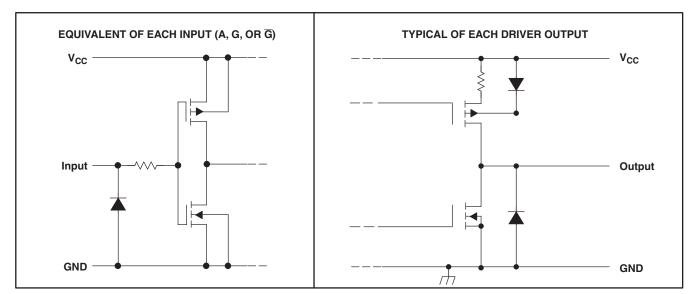
INPUT	ENA	BLES	OUTPUTS		
Α	G	G	Y	Z	
Н	Н	Х	н	L	
L	н	Х	L	н	
Н	х	L	н	L	
L	х	L	L	н	
Х	L	Н	Z	Z	

**FUNCTION TABLE<sup>(1)</sup>** 

(1) H = high level, L = low level, X = irrelevant, Z = high impedance (off)



#### SCHEMATIC



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#### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range <sup>(2)</sup>		-0.5	6	V
VI	Input voltage range	Input voltage range		6	V
Vo	Output voltage range		-0.5	6	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-20	mA
lo	Continuous output current			±150	mA
	Continuous current through $V_{CC}$ or (	SND		±200	mA
TJ	Operating virtual junction temperatu	e		150	°C
$\theta_{JA}$	Package thermal impedance $^{(3)(4)}$			73	°C/W
T <sub>A</sub>	Operating free-air temperature rang	)	-55	105	°C
T <sub>stg</sub>	Storage temperature range		-65	150	°C

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings (1) only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2)

All voltage values except differential input voltage are with respect to the network GND. Maximum power dissipation is a function of  $T_{J(max)}$ ,  $\theta_{JA}$ , and  $T_A$ . The maximum allowable power dissipation at any allowable ambient temperature is  $P_D = (T_{J(max)} - T_A)/\theta_{JA}$ . Selecting the maximum of 150°C can affect reliability. The package thermal impedance is calculated in accordance with JESD 51-7. (3)

(4)

## **RECOMMENDED OPERATING CONDITIONS**

		MIN	NOM	MAX	UNIT
V <sub>CC</sub>	Supply voltage	3	3.3	3.6	V
VI	Input voltage	0		5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
I <sub>OH</sub>	High-level output current			-30	mA
I <sub>OL</sub>	Low-level output current			30	mA
T <sub>A</sub>	Operating free-air temperature	-55		105	°C

## **ELECTRICAL CHARACTERISTICS**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>OH</sub>	High-level output voltage	$V_{IH} = 2 \text{ V}, \text{ V}_{IL} = 0.8 \text{ V}, \text{ I}_{OH} = -20 \text{ mA}$	2.4	3		V
V <sub>OL</sub>	Low-level output voltage	$V_{IH} = 2 \text{ V}, \text{ V}_{IL} = 0.8 \text{ V}, \text{ I}_{OL} = 20 \text{ mA}$		0.2	0.4	V
V <sub>OD1</sub>	Differential output voltage	$I_{O} = 0 \text{ mA}$	2		4	V
V <sub>OD2</sub>	Differential output voltage	$R_L = 100 \Omega$ (see Figure 1) <sup>(2)</sup>	2	2.6		V
$\Delta  V_{OD} $	Change in magnitude of differential output voltage	$R_L = 100 \ \Omega$ (see Figure 1) <sup>(2)</sup>			±0.4	V
V <sub>OC</sub>	Common-mode output voltage	$R_L = 100 \Omega$ (see Figure 1) <sup>(2)</sup>		1.5	2	V
$\Delta  V_{OC} $	Change in magnitude of common-mode output voltage	$R_L = 100 \ \Omega$ (see Figure 1) <sup>(2)</sup>			±0.4	V
I <sub>O(OFF)</sub>	Output current with power off	$V_{CC} = 0, V_{O} = -0.25 \text{ V or } 5.5 \text{ V}$			±127	μA
I <sub>OZ</sub>	High-impedance state output current	$V_{O} = -0.25$ V or 5.5 V, G = 0.8 V or $\overline{G} = 2$ V			±127	μΑ
l <sub>l</sub>	Input current	$V_{CC} = 0 \text{ or } 3.6 \text{ V}, \text{ V}_{I} = 0 \text{ or } 5.5 \text{ V}$			±10	μΑ
I <sub>OS</sub>	Short-circuit output current	$V_{O} = V_{CC} \text{ or } GND^{(3)}$	-30		-150	mA
I <sub>CC</sub>	Supply current (total package)	$V_I = V_{CC}$ or GND, No load, enable			100	μΑ
C <sub>pd</sub>	Power dissipation capacitance	No load <sup>(4)</sup>		160		pF

(1)

All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C. Refer to TIA-EIA-422-B for exact conditions. Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.  $C_{pd}$  determines the no-load dynamic current consumption:  $I_S = C_{pd} \times V_{CC} \times f + I_{CC}$ (2) (3)

(4)



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## SWITCHING CHARACTERISTICS

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
t <sub>PHL</sub>	Propagation delay time, high- to low-level output		4	8	12	ns
t <sub>PLH</sub>	Propagation delay time, low- to high-level output	See Figure 2	3.5	8	12	ns
tt	Transition time (t <sub>r</sub> or t <sub>f</sub> )	See Figure 2		5	10	ns
t <sub>PZH</sub>	Output-enable time to high level	See Figure 3		10	20	ns
t <sub>PZL</sub>	Output-enable time to low level	See Figure 4		10	20	ns
t <sub>PHZ</sub>	Output-disable time from high level	See Figure 3		10	20	ns
t <sub>PLZ</sub>	Output-disable time from low level	See Figure 4		10	20	ns
t <sub>sk(p)</sub>	Pulse skew			0.5	3	ns
t <sub>sk(o)</sub>	Skew limit (pin to pin)	See Figure 2 <sup>(2)(3)</sup>			1.5	ns
t <sub>sk(lim)</sub>	Skew limit (device to device)				3	ns
f <sub>(max)</sub>	Maximum operating frequency	See Figure 2		32		MHz

All typical values are at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C.
 Pulse skew is defined as the |t<sub>PLH</sub> - t<sub>PHL</sub>| of each channel of the same device.
 Skew limit (device to device) is the maximum difference in propagation delay times between any two channels of any two devices.

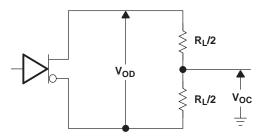
#### **ESD PROTECTION**

PARAMETER	TEST CONDITIONS	TYP	UNIT
	HBM	±15	
Driver output	IEC61000-4-2, Air-Gap Discharge		kV
	IEC61000-4-2, Contact Discharge	±8	

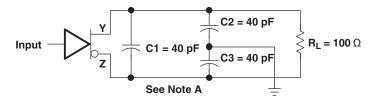
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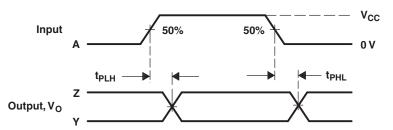
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#### PARAMETER MEASUREMENT INFORMATION

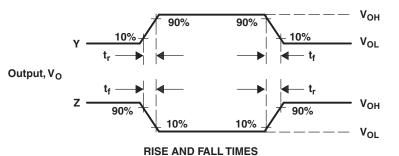








PROPAGATION DELAY TIMES



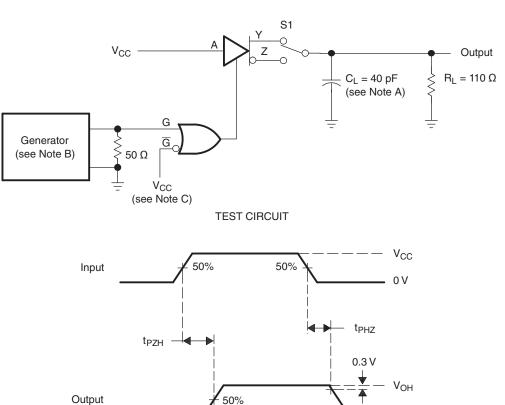
- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. The input pulse is supplied by a generator having the following characteristics: PRR = 32 MHz, 50% duty cycle,  $t_r$  and  $t_f \le 2$  ns.

#### Figure 2. Test Circuit and Voltage Waveforms, t<sub>PHL</sub> and t<sub>PLH</sub>

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## PARAMETER MEASUREMENT INFORMATION (continued)

- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The input pulse is supplied by a generator having the following characteristics: PRR = 10 MHz, duty cycle = 50%,  $t_r = t_f \le 2ns$ .
- C. To test the active-low enable  $\overline{G}$ , ground G and apply an inverted waveform  $\overline{G}$ .

#### Figure 3. Test Circuit and Voltage Waveforms, t<sub>PZH</sub> and t<sub>PHZ</sub>

VOLTAGE WAVEFORMS

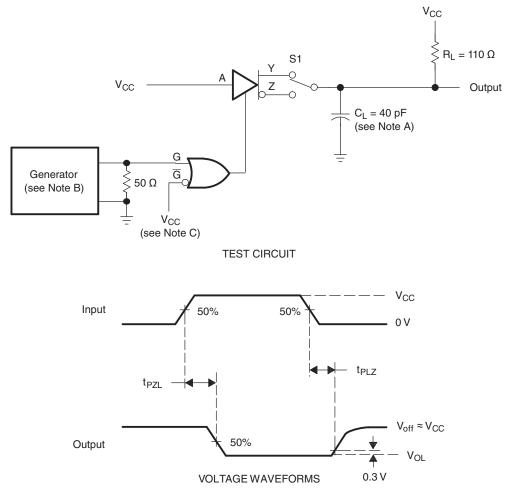
 $V_{off} \approx 0$ 

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## PARAMETER MEASUREMENT INFORMATION (continued)

- A. C<sub>L</sub> includes probe and jig capacitance.
- B. The input pulse is supplied by a generator having the following characteristics: PRR = 10 MHz, duty cycle = 50%,  $t_r = t_f \le 2ns$ .
- C. To test the active-low enable  $\overline{G}$ , ground G and apply an inverted waveform  $\overline{G}$ .

Figure 4. Test Circuit and Voltage Waveforms, t<sub>PZL</sub> and t<sub>PLZ</sub>

## PACKAGING INFORMATION

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
AM26LV31ESDREP	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
V62/09603-01XE	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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Catalog: AM26LV31E

NOTE: Qualified Version Definitions:

• Catalog - TI's standard catalog product

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



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